MOSFET – Power, **N-Channel**

100 V, 19 A, 74 m Ω

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T _J = 25°C unless otherwise noted)						
Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	100	V	
Gate-to-Source Voltag	ge – Conti	nuous	V _{GS}	±20	V	
Continuous Drain	Steady $T_C = 25^{\circ}C$		۱ _D	19	А	
Current	State	$T_{C} = 100^{\circ}C$		13		
Power Dissipation	Steady State	T _C = 25°C	PD	71	W	
Pulsed Drain Current	t _p = 10 μs		I _{DM}	70	А	
Operating and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C	
Source Current (Body Diode)			۱ _S	19	А	
Single Pulse Drain-to-Source Avalanche Energy (V _{DD} = 50 Vdc, V _{GS} = 10 Vdc, $I_{L(pk)}$ = 18.2 A, L = 0.3 mH, R _G = 25 Ω)			E _{AS}	50	mJ	
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			ΤL	260	°C	

MAYIMI IM DATINGS /T 25°C uploss otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Мах	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	47	

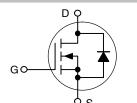
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

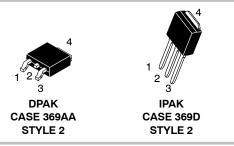


ON Semiconductor®

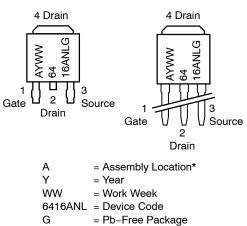
www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
100 V	74 mΩ @ 10 V	19 A





MARKING DIAGRAM & PIN ASSIGNMENTS



* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_{D} = 250 μ A		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				120		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V_{.}$	T _J = 25°C			1.0	μA
		V _{GS} = 0 V, V _{DS} = 100 V	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.0		2.2	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$				5.4		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D :	= 10 A		70	80	mΩ
		V _{GS} = 10 V, I _D =	: 10 A		62	74	1
		V _{GS} = 10 V, I _D =	: 19 A		68	74	
Forward Transconductance	9 _{FS}	V _{DS} = 5 V, I _D =	10 A		18		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	CE			•	•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			700	1000	pF
Output Capacitance	C _{OSS}				110		
Reverse Transfer Capacitance	C _{RSS}				50		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 80 V, I _D = 19 A			25	40	nC
Threshold Gate Charge	Q _{G(TH)}				0.7		1
Gate-to-Source Charge	Q _{GS}				2.4		1
Gate-to-Drain Charge	Q _{GD}				9.6		
Plateau Voltage	V _{GP}				3.2		V
Gate Resistance	R _G				2.4		Ω
SWITCHING CHARACTERISTICS (No	te 3)					-	
Turn-On Delay Time	t _{d(on)}				7.0		ns
Rise Time	t _r	V_{GS} = 10 V, V_{DD} = 80 V, I_{D} = 19 A, R_{G} = 6.1 Ω			16		1
Turn-Off Delay Time	t _{d(off)}				35		1
Fall Time	t _f				40		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				•	•	
Forward Diode Voltage	V _{SD}		$T_J = 25^{\circ}C$		0.9	1.2	V
		$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 19 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.72		1
Reverse Recovery Time	t _{RR}		•		50		ns
Charge Time	T _a	V_{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 19 A			38		1
Discharge Time	Т _b				14		

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise noted)

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

112

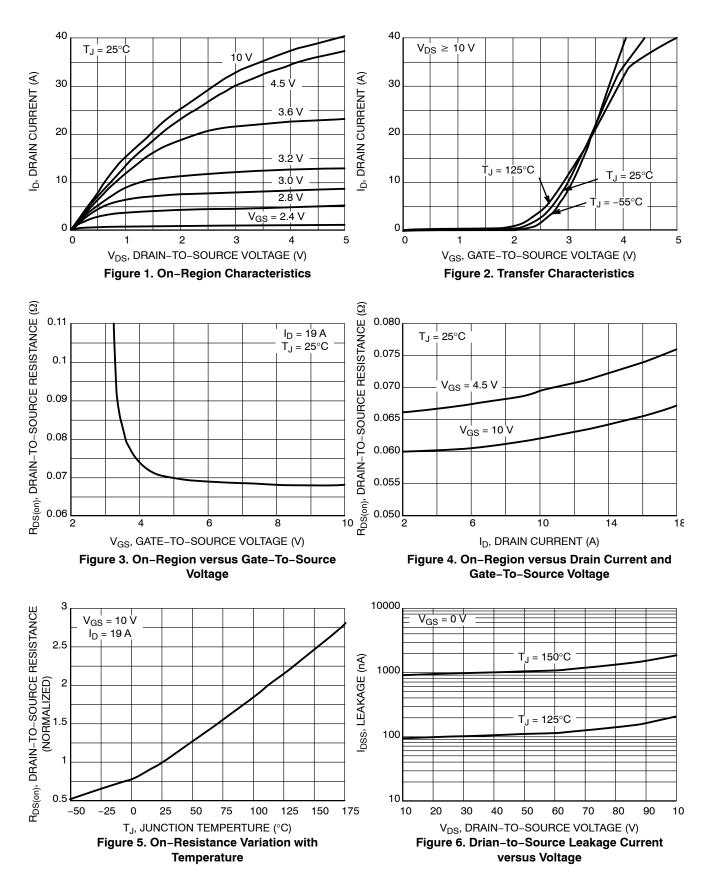
nC

Reverse Recovery Charge

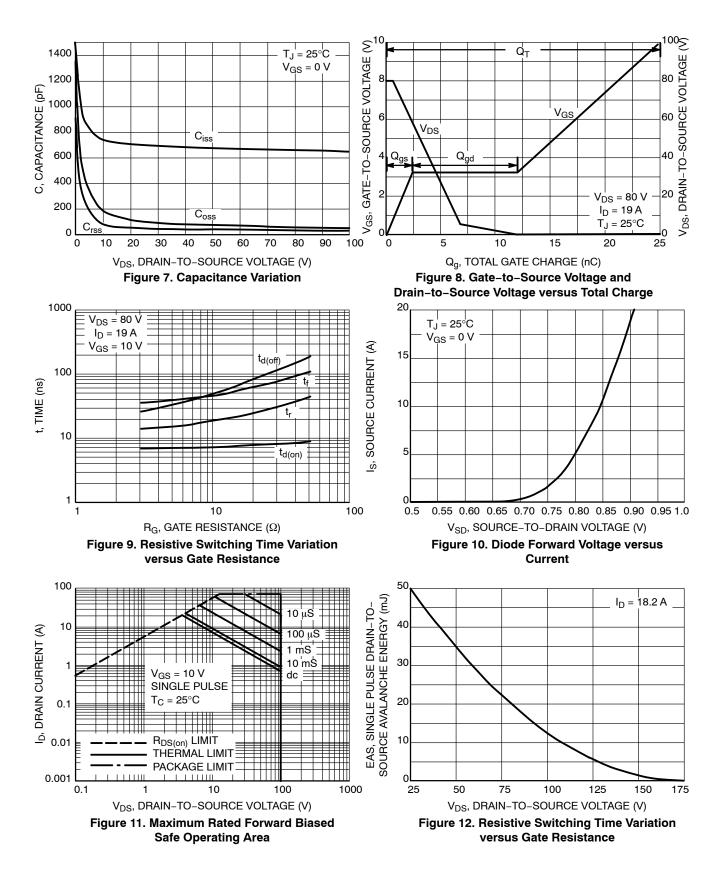
3. Switching characteristics are independent of operating junction temperatures.

Q_{RR}

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

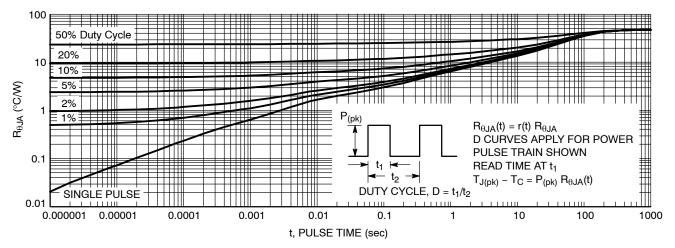


Figure 13. Thermal Response (NTD6416ANL DPAK PCB Cu Area 720 mm² PCB Cu thk 2 oz)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTD6416ANLT4G	DPAK (Pb–Free)	2500 / Tape & Reel
NTD6416ANL-1G	IPAK (Pb-Free)	75 Units / Rail
NVD6416ANLT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
NVD6416ANLT4G-VF01*	DPAK (Pb–Free)	2500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

*NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable.

DATE 15 DEC 2010



IPAK CASE 369D-01 **ISSUE C** С в -SCALE 1:1 v Ε R 7 4 Α S 2 3 1 -T-7 SEATING PLANE κ J F ·H D 3 PL G 🖛 🔶 0.13 (0.005) 🔘 T STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE STYLE 1: PIN 1. BASE STYLE 4: PIN 1. CATHODE

DRAIN
SOURCE

4. DRAIN

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

4. MT2 2. CATHODE

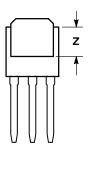
4. CATHODE

COLLECTOR

3. ANODE

STYLE 7: PIN 1. GATE 2. COLLECTOR 3. EMITTER

4.



ANODE
GATE

4. ANODE

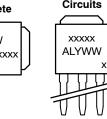
NOTES:

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
к	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

MARKING DIAGRAMS

Integrated Circuits Discrete YWW XXXXXXXX



xxxxxxxx = Device Code А = Assembly Location IL = Wafer Lot Y = Year WW = Work Week

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2. COLLECTOR

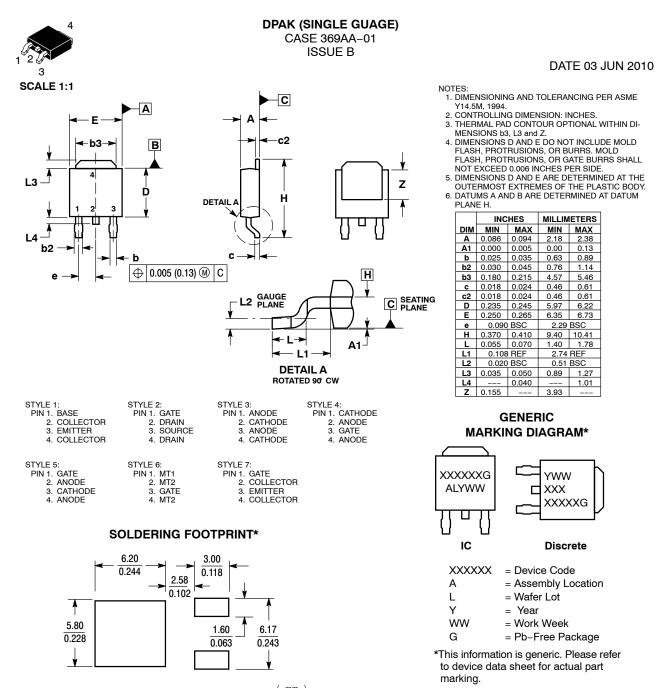
4. COLLECTOR

3. EMITTER

STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE

4. ANODE





mm SCALE 3:1 inches

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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